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Attorney's Docket No.: 15670-029US1/SD2003-252

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

oplicant : Chung-Kuan Cheng, et al. Art Unit: Unassigned
Serial No.: 10/558,842 Examiner: Unassigned

Filed: November 29, 2005

Title : CIRCUIT NETWORK ANALYSIS USING ALGEBRAIC MULTIGRID

APPROACH

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Applicants call attention to the attached Information
Disclosure Statement and documents listed on form PTO-1449.

This filing is being made before the receipt of a first Office action on the merits. No fee is required.

The documents are in the English language; hence no concise explanation is necessary per Rule 98(a)(3).

Consideration of the foregoing and enclosures plus the return of a copy of the enclosed form PTO-1449 with the

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Examiner's initials in the left column per MPEP 609 are earnestly solicited along with an early action on the merits.

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Respectfully submitted,

Date:April 18, 2006

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	Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attomey's Docket No. 15670-029US1	Application No. 10/558,842
by Applicant (Use several sheets if necessary)		Applicant Chung-Kuan Cheng, et al.		
		Filing Date	Group Art Unit	
		November 29, 2005	Unassigned	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	6,577,992	06//10/03	Tcherniaev et al.			

	Foreign Patent Documents or Published Foreign Patent Applications							
Examiner	Desig.	Document	Publication	Country or			Trans	lation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AB	2004/109452	12/16/04	PCT				

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Examiner Signature	Date Considered		
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with			
next communication to applicant			

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 15670-029US1	Application No. 10/558,842	
	losure Statement plicant	Applicant Chung-Kuan Cheng, et al.		
(Use several sheets if necessary) (37 CFR §1.98(b))		Filing Date November 29, 2005	Group Art Unit Unassigned	

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